SN54HC594, SN74HC594 8-BIT SHIFT REGISTERS WITH OUTPUT REGISTERS SCLS040C – DECEMBER 1982 – REVISED FEBRUARY 1998

- 8-Bit Serial-In, Parallel-Out Shift Registers With Storage
- Independent Direct Overriding Clears on Shift and Storage Registers
- Independent Clocks for Both Shift and Storage Registers
- High-Current Outputs Can Drive Up to 15 LSTTL Loads
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

The 'HC594 devices contain an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. Separate clocks and direct overriding clear (\overline{RCLR} , \overline{SRCLR}) inputs are provided on both the shift and storage registers. A serial ($Q_{H'}$) output is provided for cascading purposes.

Both the shift register (RCLK) and storage register (SRCLK) clocks are positive edge triggered. If both clocks are connected together, the shift register is always one count pulse ahead of the storage register.

The parallel $(Q_A - Q_H)$ outputs have high-current capability. $Q_{H'}$ is a standard output.

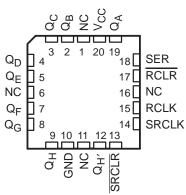
Q_B $16 V_{CC}$ 1 15 Q_A Q_C[2 14 SER Q_D 3 Q_E 13 RCLR 4 Q_F 12 RCLK 5 Q_G [11 SRCLK 6 10 SRCLR Q_H [7] Q_{H′} 9 GND 8

SN54HC594 ... J OR W PACKAGE

SN74HC594 . . . D, DB, OR N PACKAGE

(TOP VIEW)

SN54HC594 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The SN54HC594 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HC594 is characterized for operation from –40°C to 85°C.



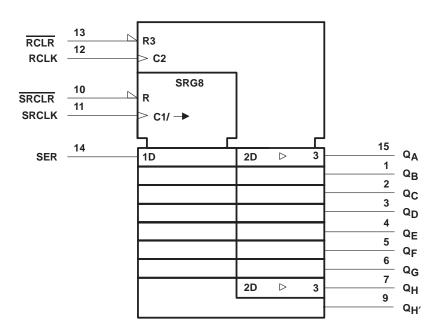
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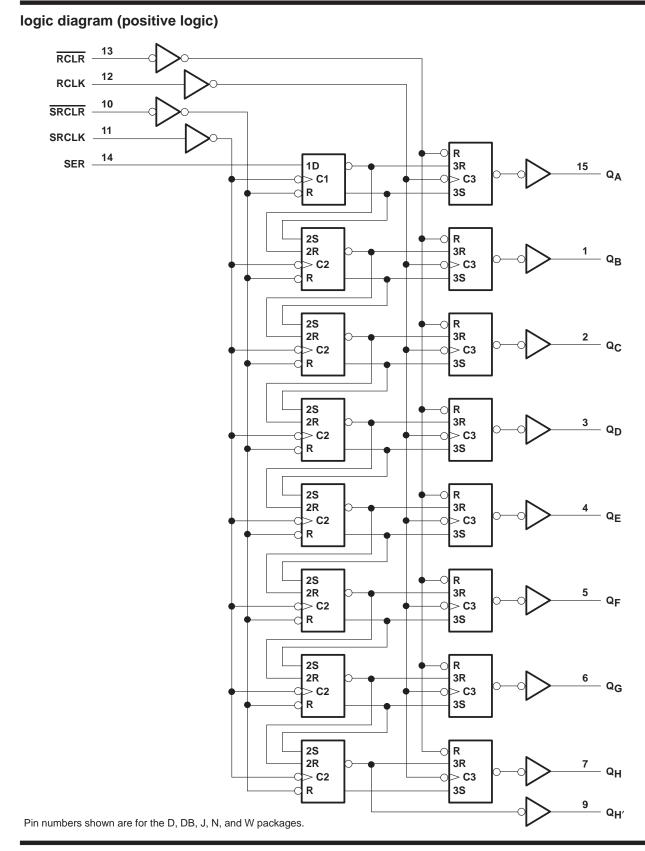
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logic symbol[†]



 † This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, N, and W packages.







absolute maximum ratings over operating free-air temperature range[†]

Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Not Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) (see Continuous output current, I_O ($V_O = 0$ to V_{CC}) Continuous current through V_{CC} or GND Package thermal impedance, θ_{JA} (see Note 2): D p DB	-0.5 V to 7 V te 1)
	ackage
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions (see Note 3)

			SN	154HC59	94	SN74HC594		UNIT	
			MIN	NOM	MAX	MIN	NOM	-	
VCC	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
VIH	High-level input voltage	V _{CC} = 4.5 V	3.15		1	3.15			V
		V _{CC} = 6 V	4.2		51	4.2			
	Low-level input voltage	$V_{CC} = 2 V$	0	ĨEL	0.5	0		0.5	V
VIL		V _{CC} = 4.5 V	0	2	1.35	0		1.35	
		V _{CC} = 6 V	0	S.	1.8	0		1.8	
VI	Input voltage		0	2	VCC	0		VCC	V
Vo	Output voltage		0		VCC	0		VCC	V
		V _{CC} = 2 V	0		1000	0		1000	
t _t	Input transition (rise and fall) time	V _{CC} = 4.5 V	0		500	0		500	ns
		V _{CC} = 6 V	0		400	0		400	
Тд	Operating free-air temperature		-55		125	-40		85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



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	TEST CONDITIONS			Т	A = 25°C	;	SN54F	IC594	SN74HC594		LINUT
PARAMETER			VCC	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
∨он	$V_I = V_{IH} \text{ or } V_{IL}$	$Q_{H'}$, $I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		V
		$Q_A - Q_H$, $I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		Q _{H'} , I _{OH} = -5.2 mA	6 V	5.48	5.8		5.2	EW	5.34		
		$Q_A - Q_H$, $I_{OH} = -7.8$ mA		5.48	5.8		5.2	EL	5.34		
	VI = VIH or VIL	I _{OL} = 20 μA	2 V		0.002	0.1		0.1		0.1	
			4.5 V		0.001	0.1	<u></u>	0.1		0.1	
			6 V		0.001	0.1	20	0.1		0.1	
VOL		Q _{H'} , I _{OL} = 4 mA	4.5 V		0.17	0.26	X	0.4		0.33	V
		$Q_A - Q_H$, $I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26	1	0.4		0.33	
		Q _{H'} , I _{OL} = 5.2 mA	6 V		0.15	0.26		0.4		0.33	
		$Q_A - Q_H$, $I_{OL} = 7.8 \text{ mA}$	0.		0.15	0.26		0.4		0.33	
Ц	$V_{I} = V_{CC} \text{ or } 0$		6 V		±0.1	±100		±1000		±1000	nA
loz	$V_{O} = V_{CC} \text{ or } 0$		6 V		±0.01	±0.5		±10		±5	μΑ
Icc	$V_I = V_{CC} \text{ or } 0,$	IO = 0	6 V			8		160		80	μΑ
Ci			2 V to 6 V		3	10		10		10	pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)



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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			N	T _A = 2	25°C	SN54H	IC594	SN74H	IC594	UNIT
			Vcc	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V		5		3.3		4	
fclock	fclock Clock frequency		4.5 V		25		17		20	MHz
			6 V		29		20		24	
			2 V	100		150		125		
		SRCLK or RCLK high or low	4.5 V	20		30		25		
tw	Pulse duration		6 V	17		25		21		ns
۳W			2 V	100		150		125		115
		SRCLR or RCLR low	4.5 V	20		30		25		
			6 V	17		25		21		
		SER before SRCLK [↑]	2 V	90		135	2	110		
			4.5 V	18		27	VIE	22		
			6 V	15		23	A.	19		
		SRCLK [↑] before RCLK ^{↑†}	2 V	90		135		110		
			4.5 V	18		27		22		
			6 V	15		23		19		
			2 V	50		Q 75		63		
t _{su}	Setup time	SRCLR low before RCLK1	4.5 V	10		15		13		ns
			6 V	9		13		11		
			2 V	20		20		20		
		SRCLR high (inactive) before SRCLK1	4.5 V	10		10		10		
			6 V	10		10		10		
			2 V	5		5		5		
		RCLR high (inactive) before SRCLK↑	4.5 V	5		5		5		
			6 V	5		5		5		
			2 V	5		5		5		
th	Hold time, SER at	iter SRCLK↑	4.5 V	5		5		5		ns
			6 V	5		5		5		

[†] This setup time ensures the output register sees stable data from the shift-register outputs. The clocks may be tied together, in which case the output register is one clock pulse behind the shift register.



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DADAMETED	FROM	то	Vee	Т	₄ = 25°C	>	SN54H	IC594	SN74H	IC594	UNIT
PARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
			2 V	5	8		3.3		4		
fmax			4.5 V	25	35		17		20		MH:
			6 V	29	40		20		24		
			2 V		50	150		225		185	
	SRCLK	Q _H ′	4.5 V		20	30		45		37	
terel			6 V		15	25		38		31	ns
^t pd			2 V		50	150		225		185	
	RCLK	Q _A –Q _H	4.5 V		20	30		45		37	
			6 V		15	25	4	2 38		31	
	SRCLR	Q _{H′}	2 V		50	150	(C)	225		185	-
			4.5 V		20	30	22	45		37	
t _{PHL}			6 V		15	25	S.	38		31	ns
PHL			2 V		50	125	1	185		155	
	RCLR	Q _A –Q _H	4.5 V		20	25		37		31	
			6 V		15	21		31		26	
			2 V		38	75		110		95	95 19
		Q _H ′	4.5 V		8	15		22		19	
tt			6 V		6	13		19		16	ns
4			2 V		38	60		90		75	
		Q _A –Q _H	4.5 V		8	12		18		15	
			6 V		6	10		15		13	

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

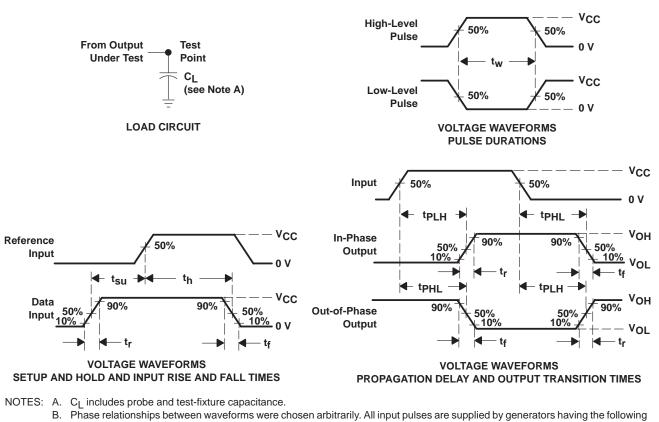
switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	Vee	Т	ן = 25°C	;	SN54HC	C594	SN74H	IC594	UNIT
FARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t pd			2 V		90	200		300		250	ns
	RCLK	Q _A –Q _H	4.5 V		23	40		60		50	
			6 V		19	34		51		43	
^t PHL	RCLR	Q _A –Q _H	2 V		90	200	2	300		250	ns
			4.5 V		23	40	S.	60		50	
			6 V		19	34	20	51		43	
			2 V		45	210	R	315		265	
tt		Q _A –Q _H	4.5 V		17	42	4	63		53	ns
			6 V		13	36		53		45	

operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	TYP	UNIT
Cpd	Power dissipation capacitance	No load	395	pF





PARAMETER MEASUREMENT INFORMATION

- characteristics: $\dot{PRR} \le 1$ MHz, $Z_{O} = 50 \ \Omega$, $t_{f} = 6$ ns, $t_{f} = 6$ ns.
- C. For clock inputs, fmax is measured when the input duty cycle is 50%.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tPLH and tPHL are the same as tpd.
- F. t_f and t_r are the same as t_t .

Figure 1. Load Circuit and Voltage Waveforms



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